

# An update on GEM detector R&D at Bose Institute

Dipanjan Nag

Centre for Astroparticle Physics & Space Science

Bose Institute



# Plan

- Motivation
- ALICE TPC
- GEM detector
- Results
- Future plan

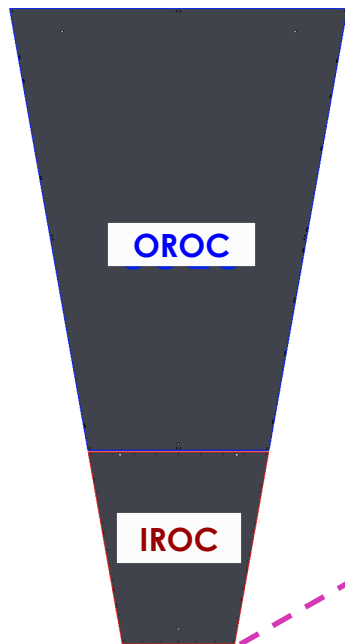


ALICE

# ALICE TPC

2 x 18

Outer Read Out Chambers



OROC

IROC

557568 pads

4 x 7.5 mm<sup>2</sup> (IROC)

6 x 10 mm<sup>2</sup> (OROC)

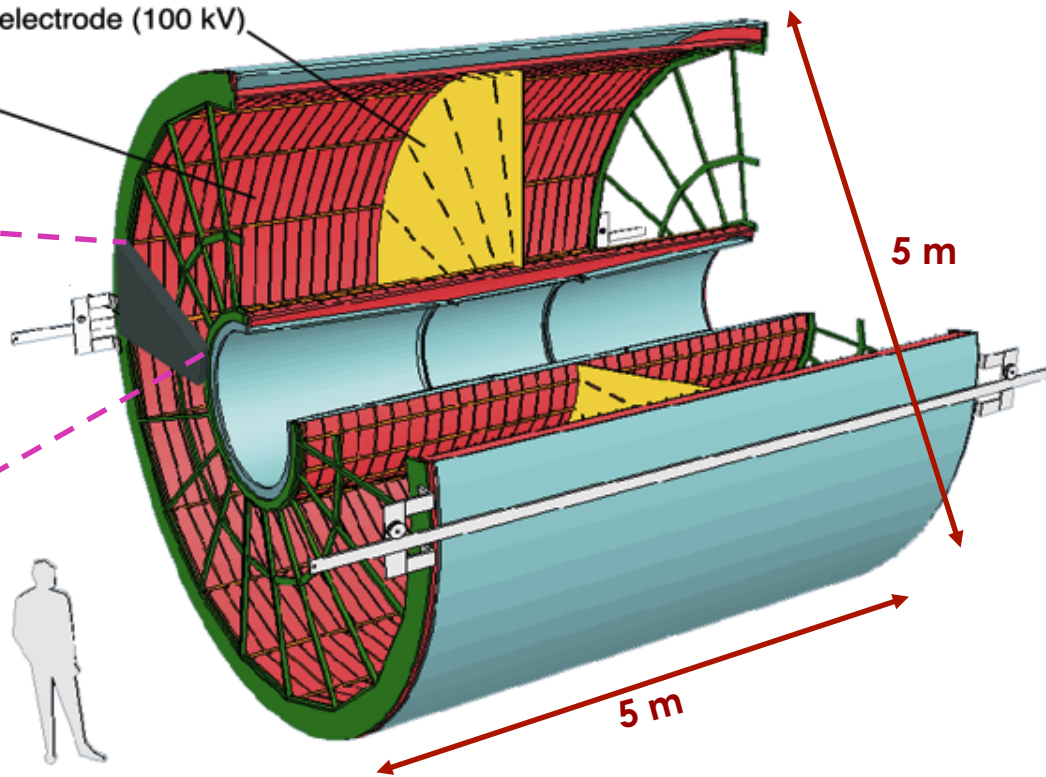
6 x 15 mm<sup>2</sup> (OROC)

2 x 18

Inner Read Out Chambers

Drift field: 400 V/cm  
HV electrode (100 kV)

field cage



5 m

5 m

## GAS:

~90 m<sup>3</sup>

Ne-CO<sub>2</sub> (90-10) in RUN1

$v_{\text{drift}} = 2.73 \text{ cm}/\mu\text{s}$  (@ 400 V/cm)

Maximum drift time: ~92  $\mu\text{s}$

- Designed for charged-particle tracking and  $dE/dx$  measurement in Pb-Pb collisions with  $dN_{\text{ch}}/d\eta = 8000$ ,  $\sigma(dE/dx)/(dE/dx) < 10\%$

- Employs gating grid to block backdrifting ions
- Rate limitations: < 3.5 kHz (in p-p), ~500 Hz (in Pb-Pb)

# ALICE TPC upgrade for RUN3

## Operate ALICE at high luminosity

( $\mathcal{L}=6 \times 10^{27} \text{ cm}^{-2}\text{s}^{-1}$ )

- Record all minimum bias events  
50 kHz Pb-Pb collisions (100× higher than present)
- Event pile-up in TPC: ~5 overlapping events
- **No gating** and **continuous readout** with GEMs

## Requirements for GEM readout:

- Operate at the gain of 2000 in Ne-CO<sub>2</sub>-N<sub>2</sub>
- IBF < 1% at Gain = 2000 →  $\epsilon = 20$
- $\sigma_E/E < 12\%$  for <sup>55</sup>Fe
- Stable operation under LHC conditions

■ + new electronics (*negative polarity, self-triggered*)

■ + novel calibration and online reconstruction schemes  
(*data compression by factor 20 and space charge distortions*)

**ALICE**  
Technical Design Report

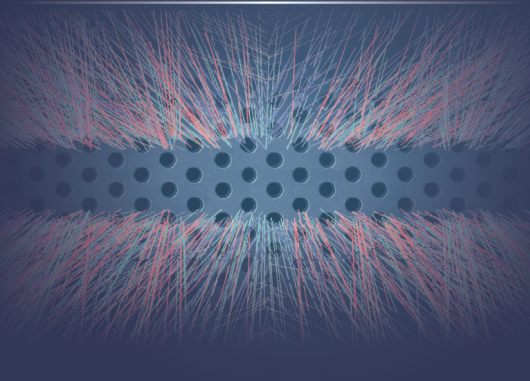
CERN-LHCC-2013-020

ALICE-TDR-016

December 5, 2013



Upgrade of the  
**Time Projection Chamber**  
Technical Design Report



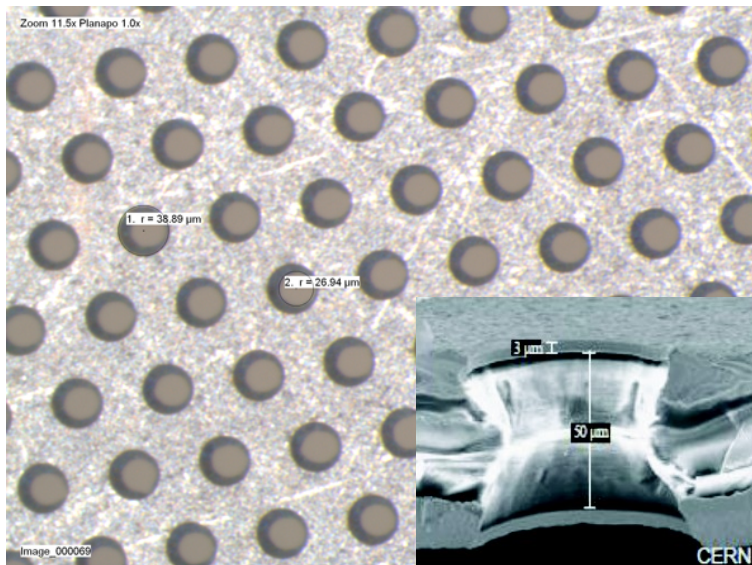
**Submitted to LHCC**



ALICE

# GEM (Gas Electron Multiplier)

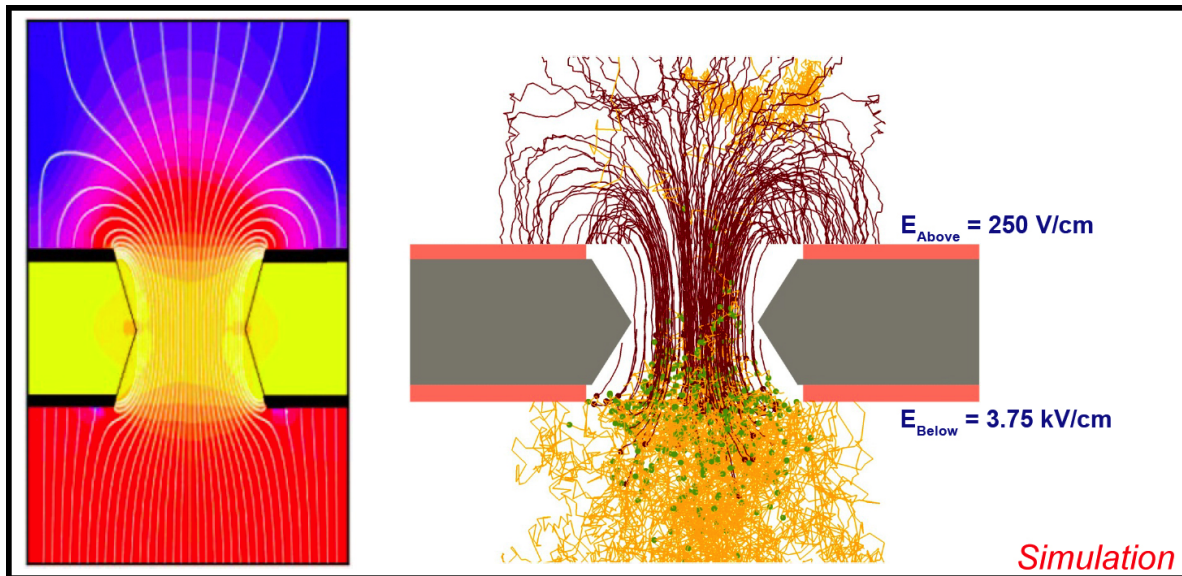
F. Sauli (1996)



- Thin polyimide foil (Kapton®) ~50 μm
- Cu-clad on both sides ~5 μm
- Photolithography: ~10<sup>4</sup> holes/cm<sup>2</sup>

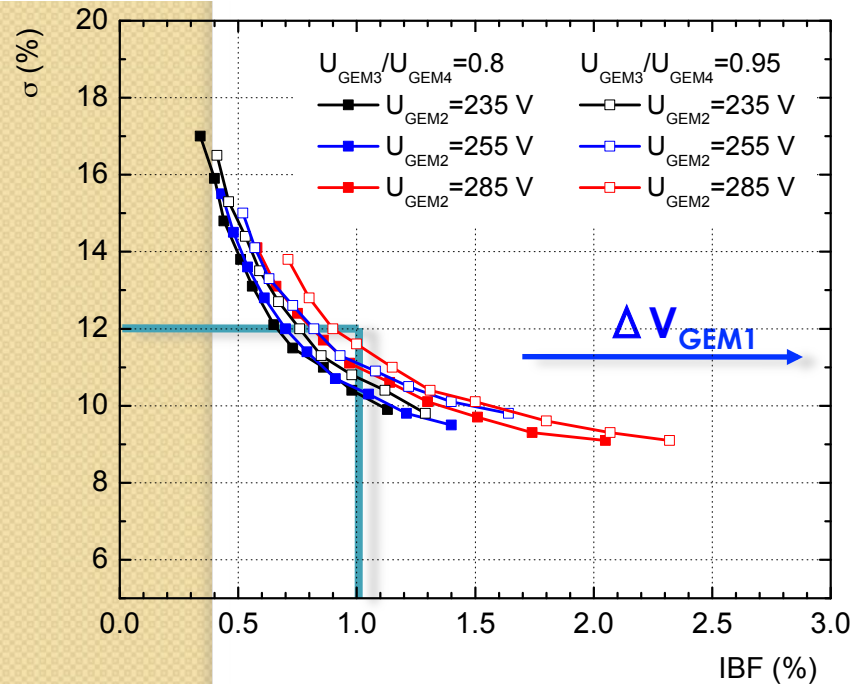
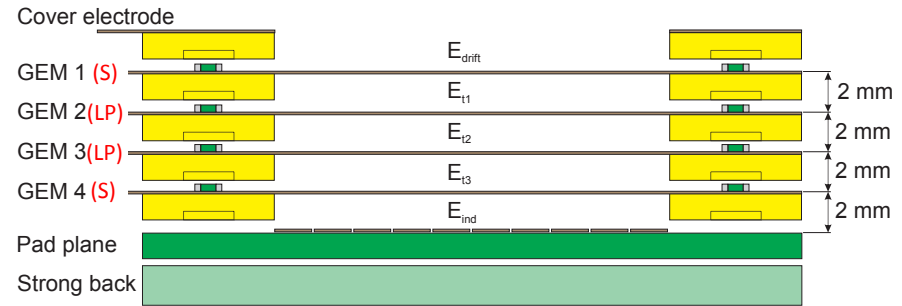
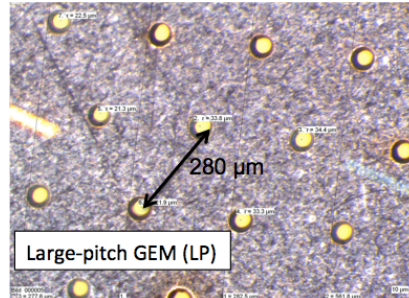
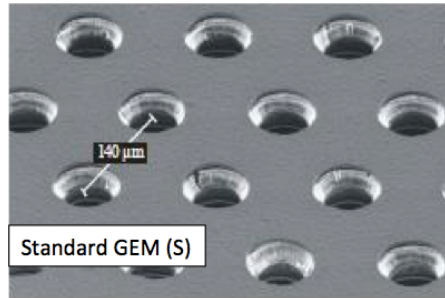
## Typical GEM geometry:

- Inner/Outer hole diameter: 50/70 μm
- **Pitch:** 140 μm



- $E_{\text{hole}}$  up to 100 kV/cm with  $\Delta V_{\text{GEM}} = 500 \text{ V}$
- $E_{\text{hole}} \gg E_{\text{above}}$   
*most of the ions are collected on the top side of GEM*
- $E_{\text{below}} > E_{\text{above}}$   
*electron extraction is improved*

# Baseline solution: 4GEM setup



- **Baseline solution performance:**

- **IBF = 0.6 %**
- $\sigma_E/E < 12$  % for 5.9 keV ( $^{55}\text{Fe}$ )
- Sufficient margin for a fine tuning of voltages (e.g. for stability).

- **R&D continues:**

- Different aspect ratios
- Different GEM geometries
- Gap distances

- **Alternative R&D**

- COBRA GEMs
- 2GEM + Micromegas

$E_{T1} = 2000$  V/cm  
 $E_{T2} = 3000$  V/cm  
 $E_{T3} = 1000$  V/cm  
 $E_{IND} = 4000$  V/cm

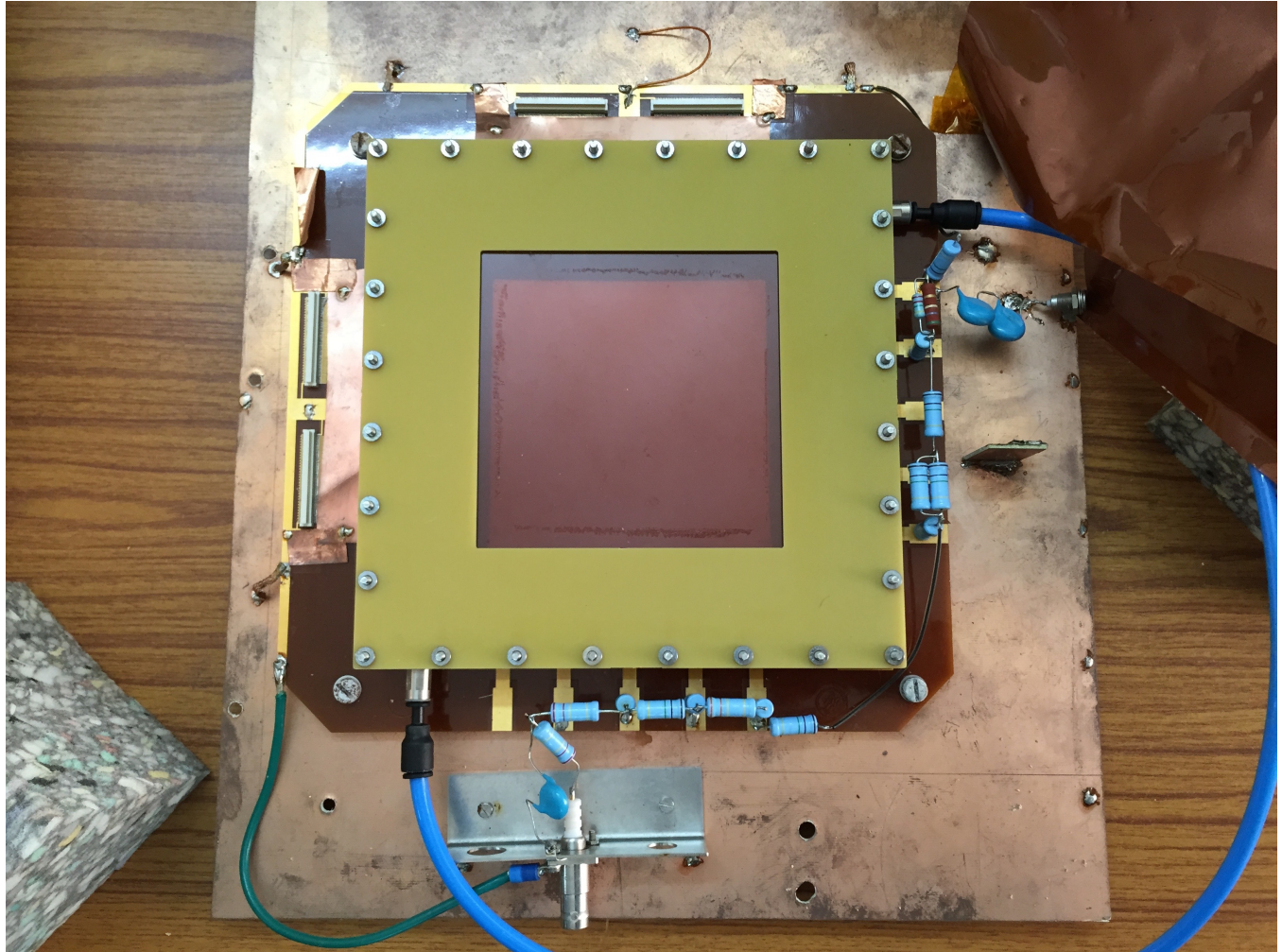
$$\Delta V_{G1} > \Delta V_{G2} \sim \Delta V_{G3} \ll \Delta V_{G4}$$

**G = 2000**

# Work done so far ....

- Characterization of a single mask triple GEM detector
- Long-term stability test of the GEM detector

# GEM detector

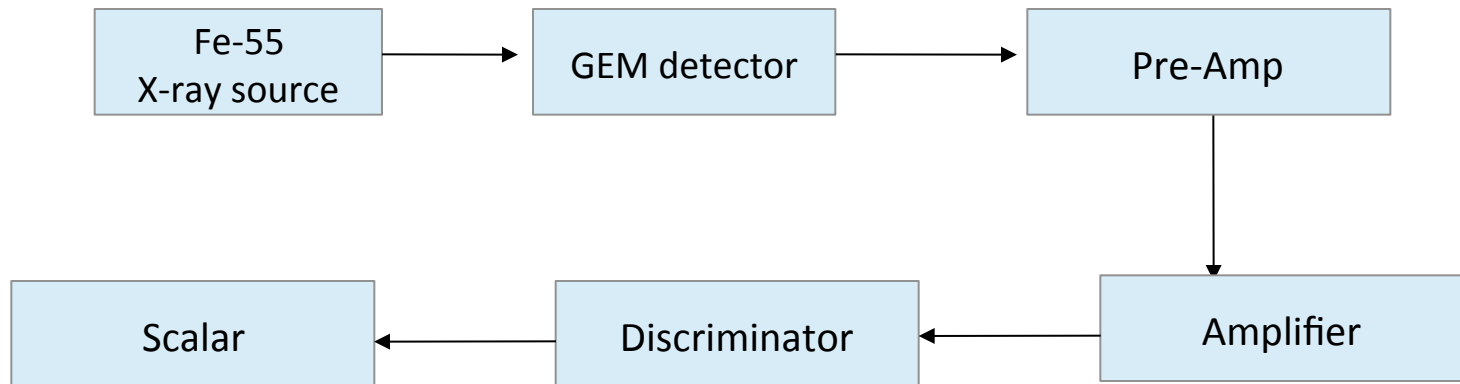




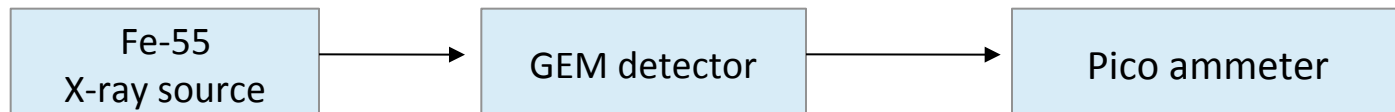
# Set-up



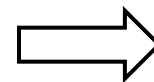
# Block diagram for count rate measurement



# Block diagram for anode current measurement

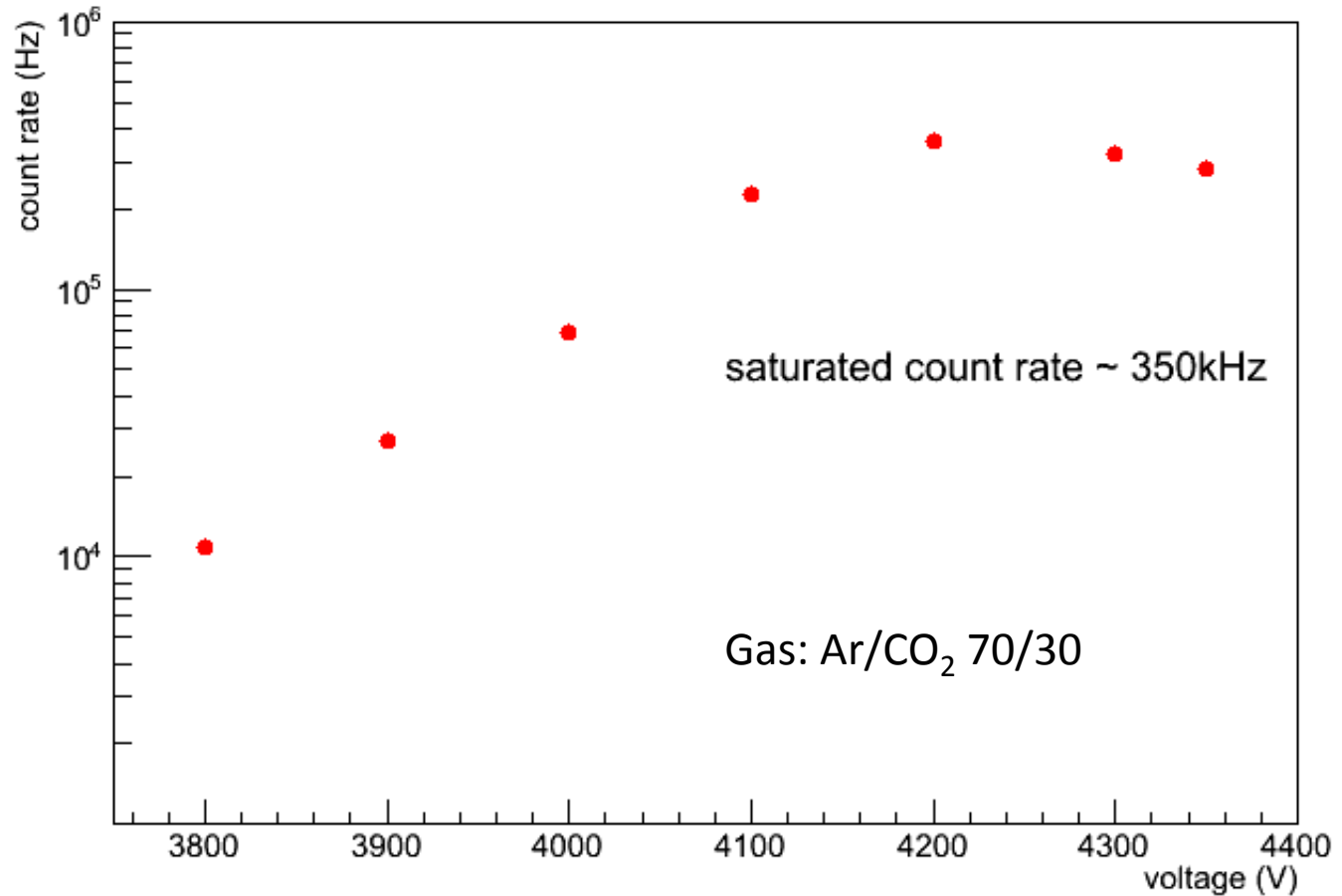


$$Gain = \frac{i_a}{rate \times primary \ no. \ of \ electrons \times e}$$

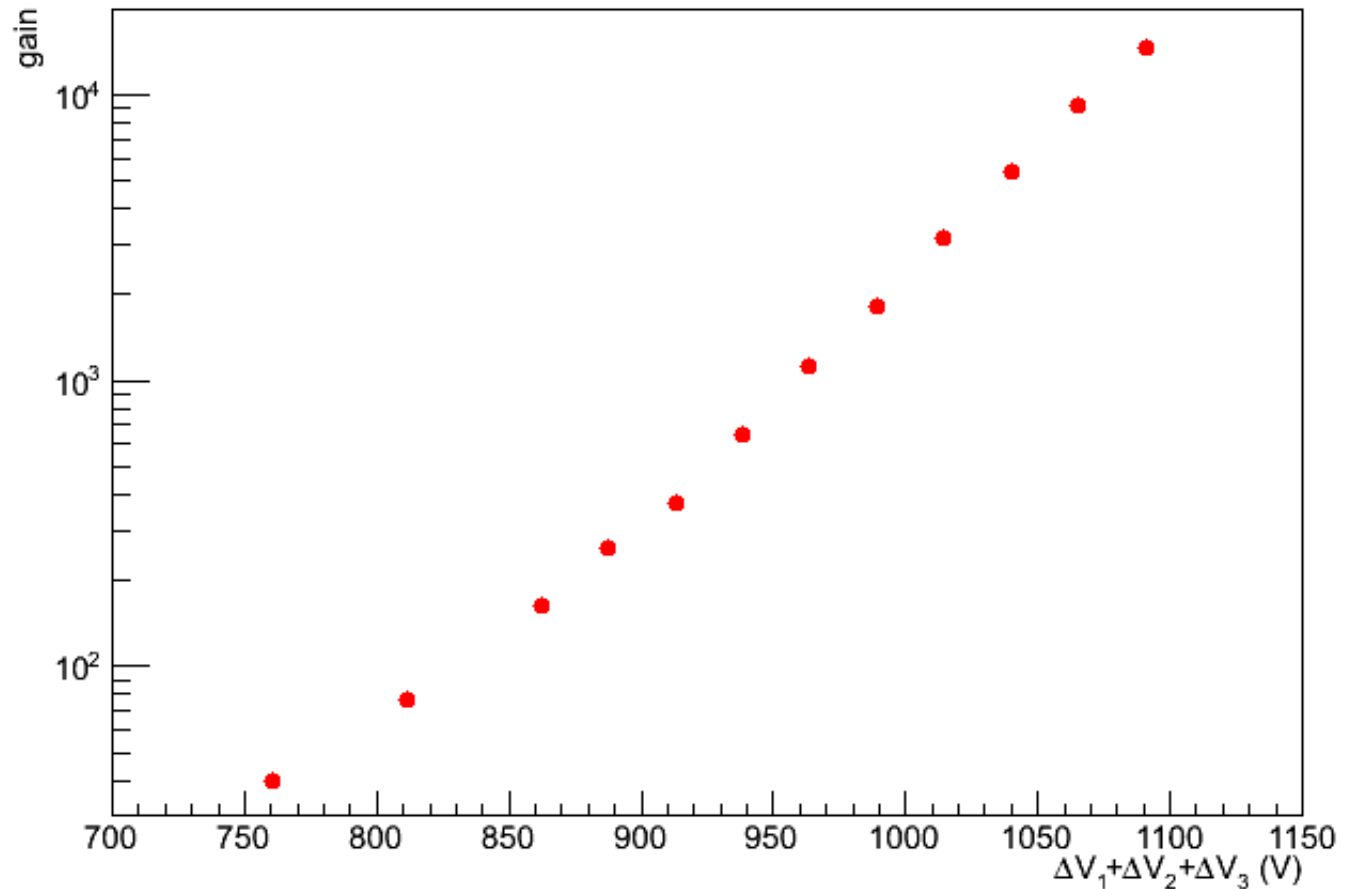


RATE used in this formula is the maximum count rate at saturation region

# Count Rate Vs. Voltage



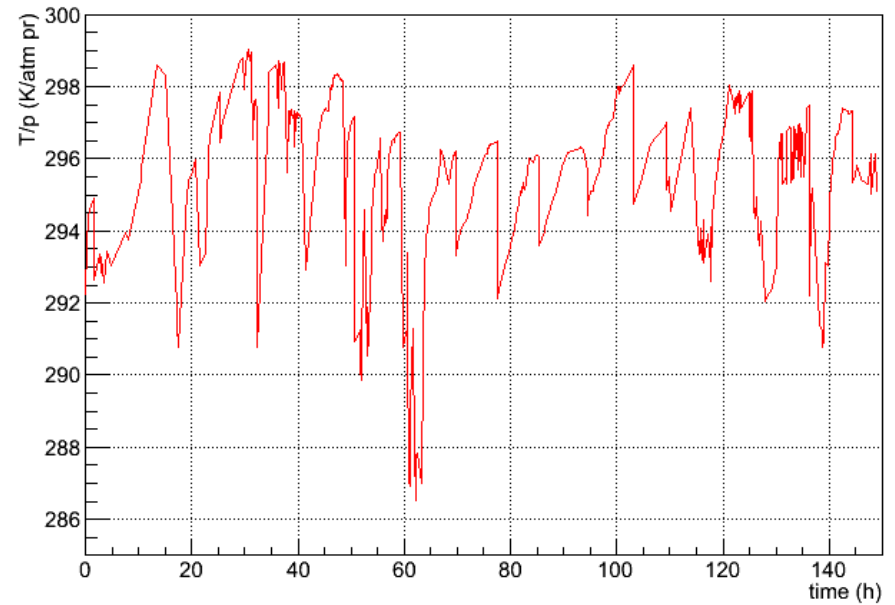
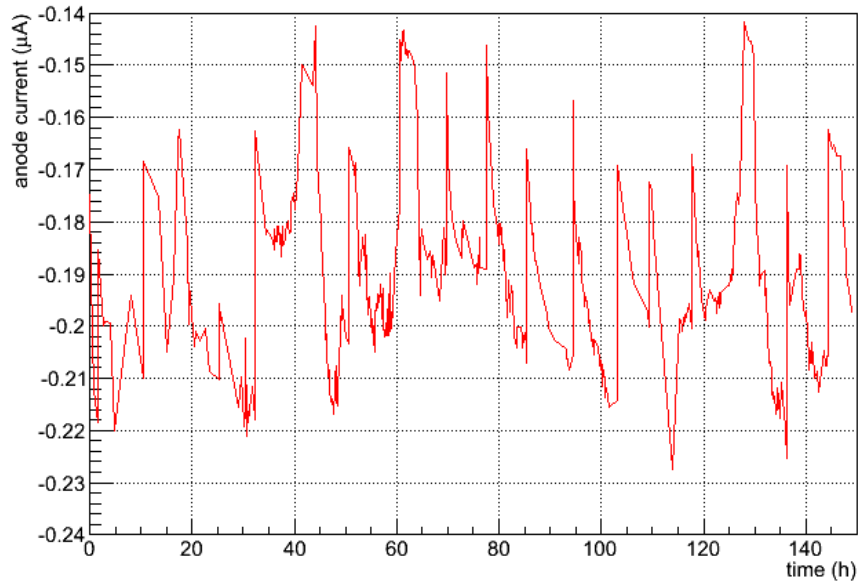
# Gain Vs. Global Voltage



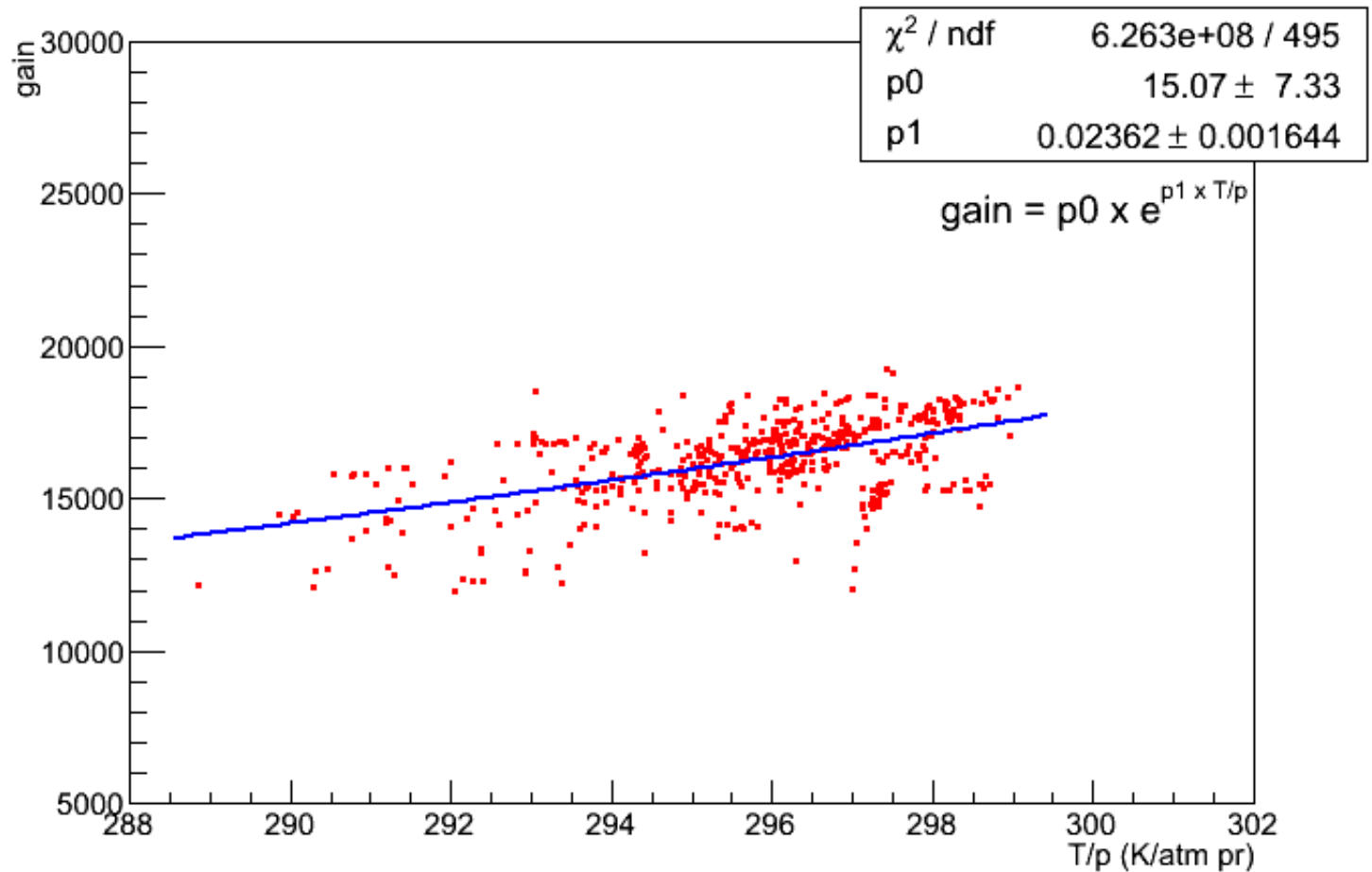
# Long term stability test

- Long term stability test is done with  $\text{Fe}^{55}$  source (100 mCi or 3.7 GBq)
- Gas: Ar/ $\text{CO}_2$  70/30
- Constant applied voltage to the divider: -4300 V
- Anode current is measured with and without source continuously (using Keithley 6485 Pico-ammeter)
- Temperature, pressure and relative humidity are measured continuously

# Anode current and T/p Vs. time



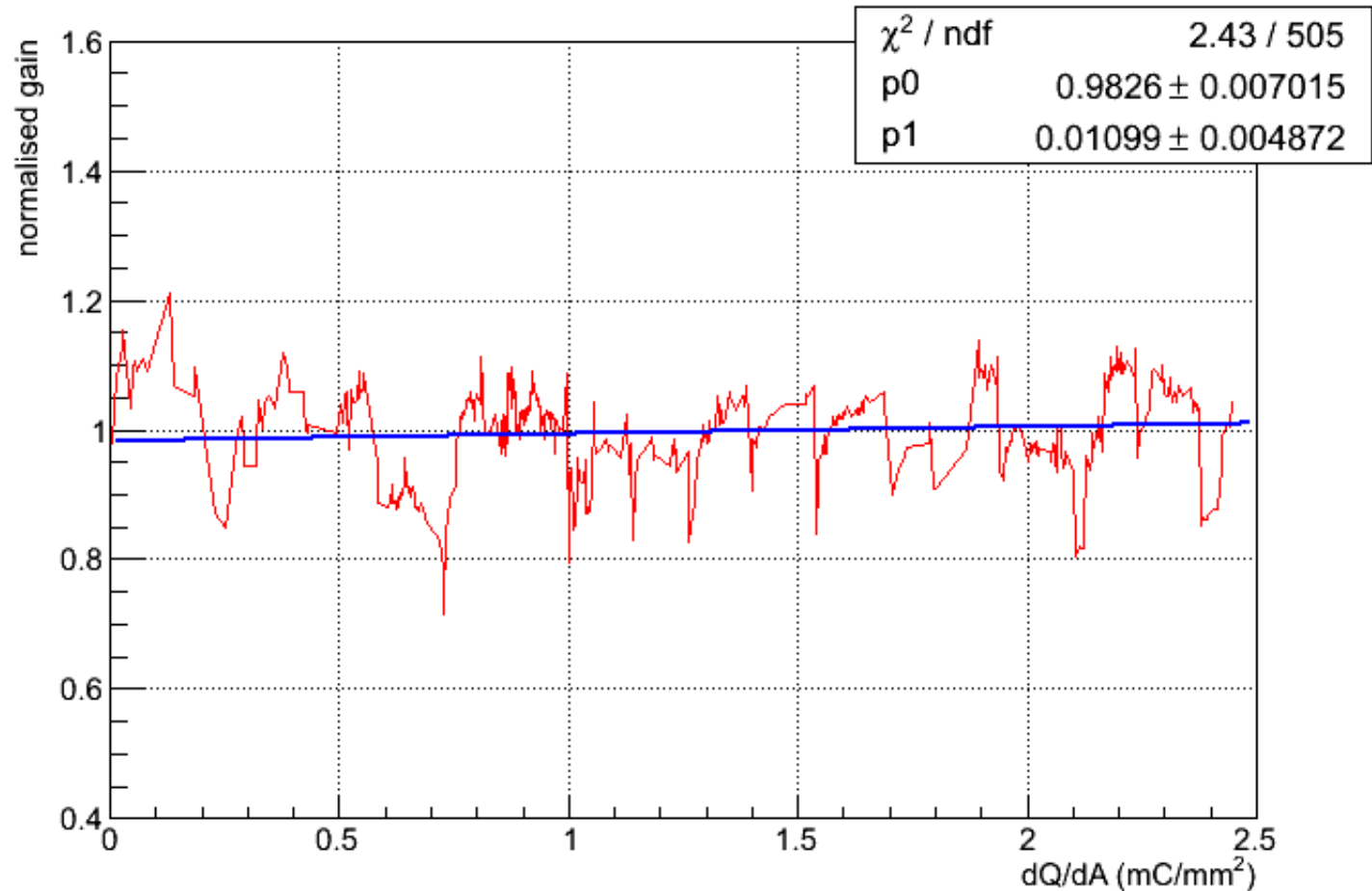
# Gain Vs. T/p



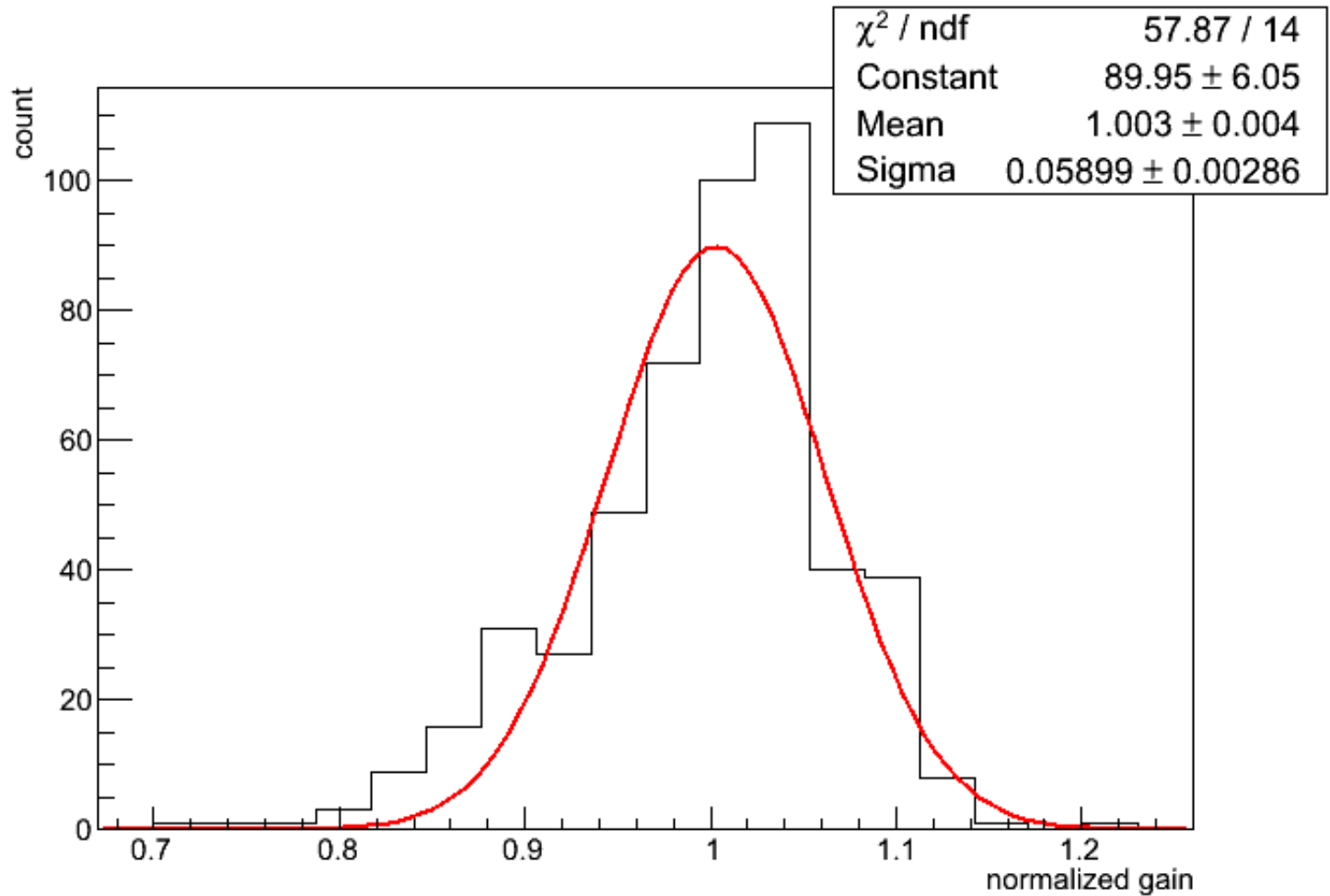


# Normalized gain Vs. $\frac{dQ}{dA}$

Normalized gain = measured gain /  $p_0 \exp(p_1 T/p)$



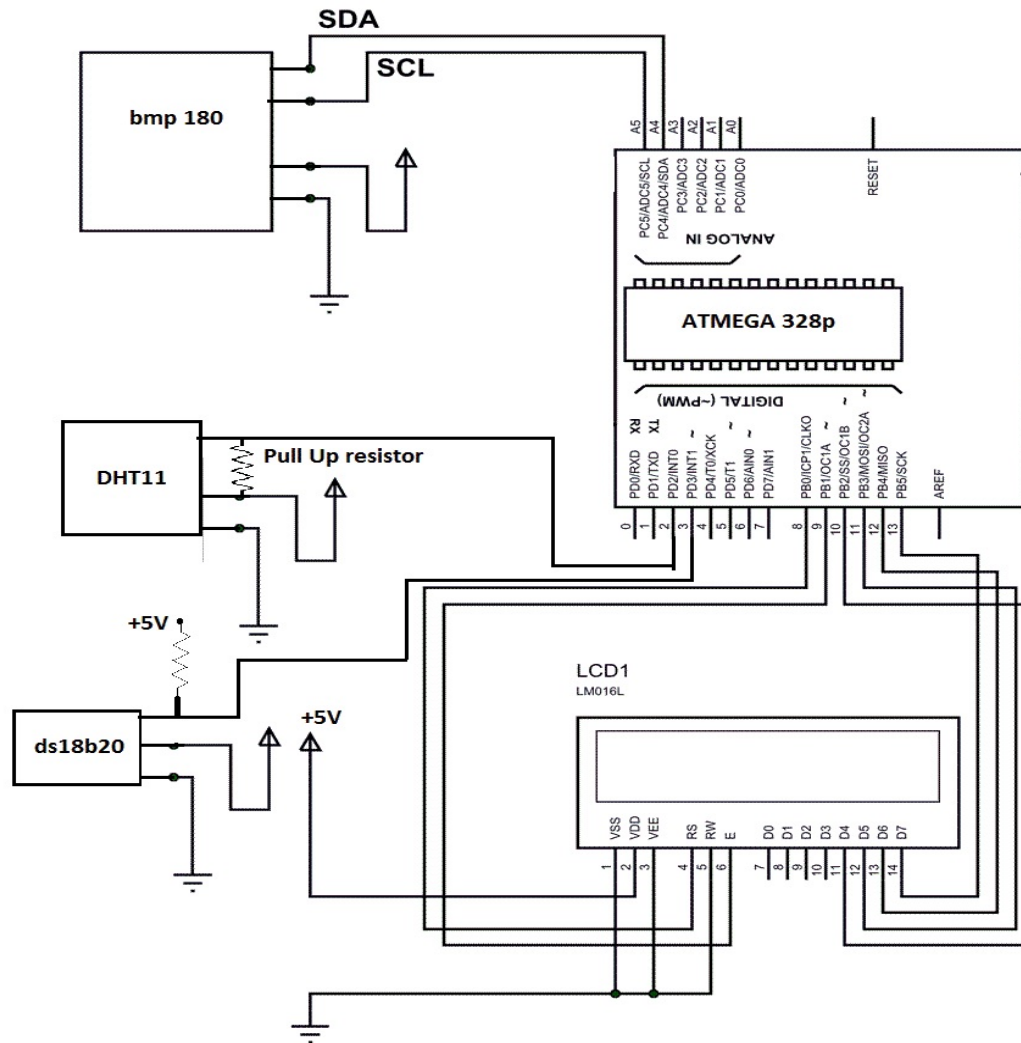
# Distribution of Normalized gain



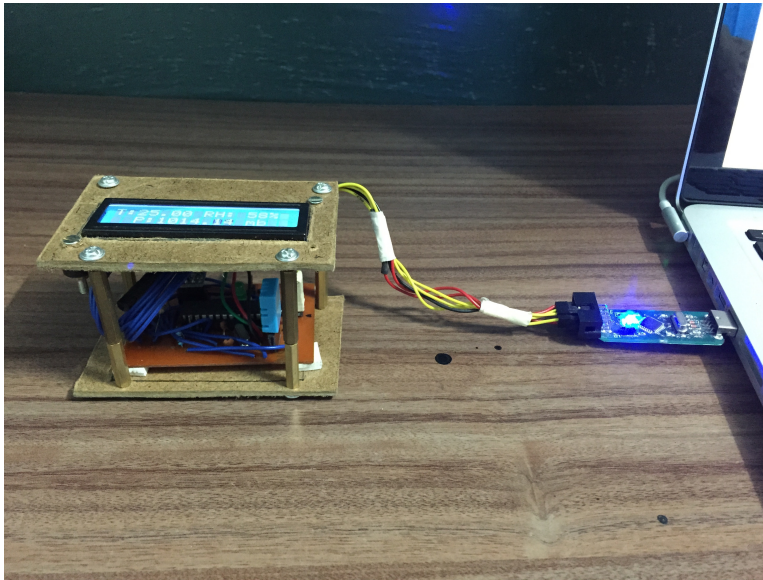
# Temperature, Pressure and Relative Humidity measurement

- Temperature sensor – ds18b20 One Wire digital Thermometer (Accuracy:  $\pm 0.5^{\circ}\text{C}$ )
  - Pressure Sensor – BMP180 Atmospheric Sensor (Accuracy: 0.02 hPa)
  - Relative Humidity Sensor – DHT11 (Accuracy:  $\pm 5\%$ )
  - Microcontroller – Atmega 328p
- 
- The Microcontroller takes the data from the sensors and displays on the Output 16 X 2 character LCD. The device operates on 5V DC supply.
  - Programme is written in C and uploaded via ISP programmer.
  - The microcontroller is a 8bit microcontroller running at 16MHz .
  - Circuit Diagram follows-

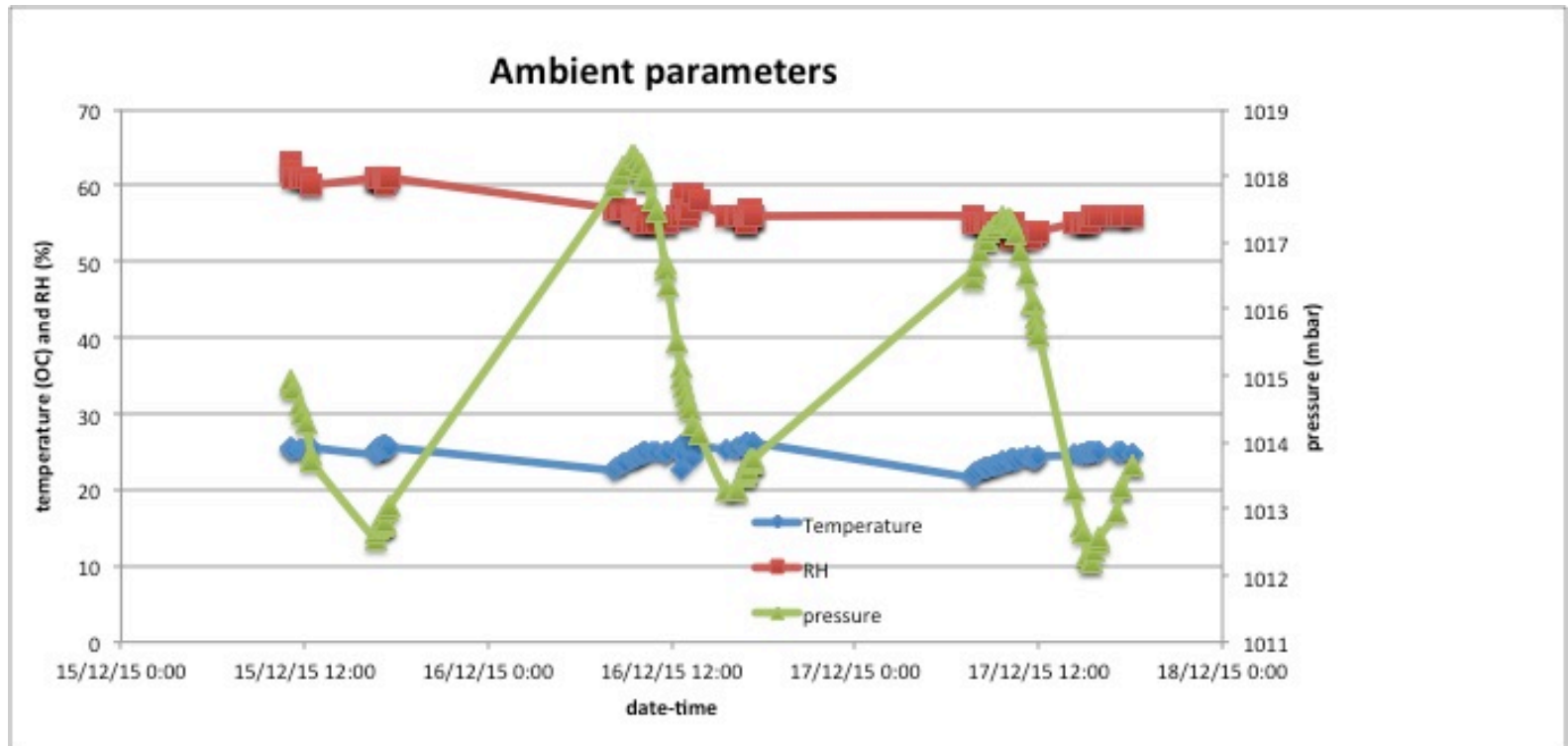
# Circuit Diagram of the Temperature, Pressure and Humidity sensor



# The data logger



# Preliminary results



# Summary

- $\sim 2.5$  mC/mm<sup>2</sup> charge is accumulated in  $\sim 150$  hours of operation
- No ageing is observed
- One instrument is built to measure the ambient parameters

## Future plan

- To build 4-GEM detector prototype
- Long-term test of 4-GEM detector

## Acknowledgement

Rama Prasad Adak and Subhojit Roy

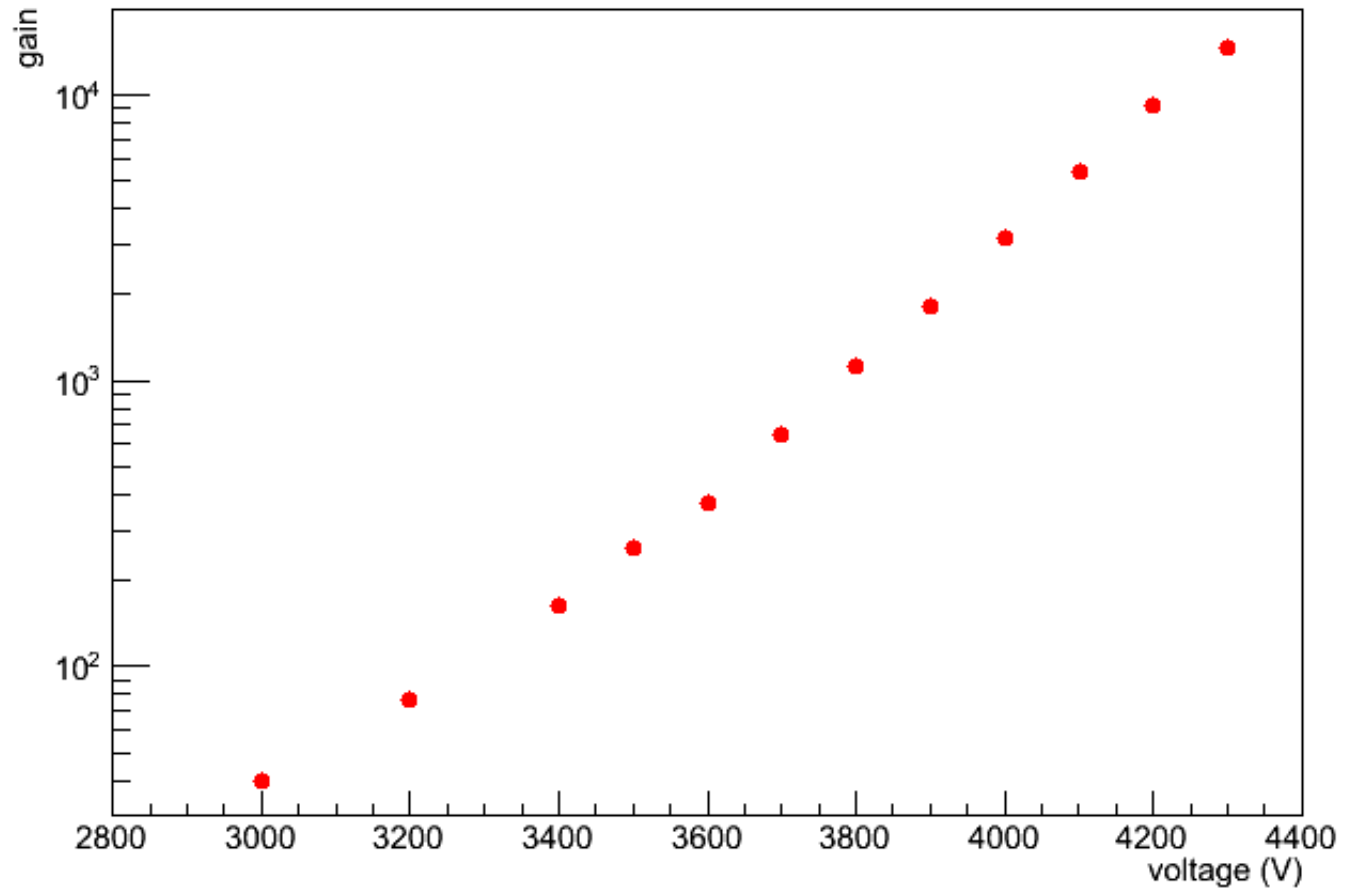
# Thank you



**Back up slides**



# Gain Vs. Applied Voltage



Normalized gain = measured gain/ $p_0 \exp(p_i T/p)$

